

CORRECTION

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Correction: Towards improved precision in the quantification of surface-enhanced Raman scattering (SERS) enhancement factors: a renewed approach

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Correction for 'Towards improved precision in the quantification of surface-enhanced Raman scattering (SERS) enhancement factors: a renewed approach' by Arumugam Sivanesan *et al.*, Analyst, 2015, DOI: 10.1039/c4an01778a.

Regarding Fig. 1–3, the following should appear in the **Acknowledgements** section:

Figures and excerpt reprinted from *Electrochemistry Communications*, A. Sivanesan, W. Adamkiewicz, G. Kalaivani, A. Kamińska, J. Waluk, R. Holyst and E. L. Izake 'Electrochemical pathway for the quantification of SERS enhancement factor', 2014, **49**, 103–106, with permission from Elsevier.

The Royal Society of Chemistry apologises for these errors and any consequent inconvenience to authors and readers.



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